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Standard Practice for Specifying the Geometry of Multiangle Spectrophotometers¹

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INTRODUCTION

The appearance of metallic coatings and plastics usually depends on the directions of illumination and viewing, a phenomenon called “gonioappearance.” This phenomenon is also observed with other materials, such as lustrous textiles and materials containing pearlescent or interference pigments. The characteristic appearance of most such materials is accentuated by directional illumination, such as that provided by the sun on a clear day or a small lamp at night. The variation in color, as a function of geometry, is usually measured by spectrophotometry with several specified sets of geometric conditions. Measurement of this kind, at a few selected angles, is called “multiangle spectrophotometry,” as distinguished from measurement over a broad range of angles, which is called “goniospectrophotometry.” Spectrophotometric aspects of these measurements, including spectral resolution and linearity of photometric scales, are treated in other standards, including Practice E308 and Practice E1164. Practice E1767 provides practice for specifying the geometry of measurements. Retroreflectors exhibit a special kind of gonioappearance, which is treated in other ASTM documents. The present document provides standard practice for specifying influx and efflux angles, angular selectivity, spatial distributions of illuminators and receivers, and angular aspects of standardizing the photometric scale, that are peculiar to multiangle spectrophotometry. Directional illumination emphasizes the gonioappearance of most materials, but when interference pigments are used, such as those used in ink to mark paper currency, the effect is observed with diffuse illumination and varying angles of viewing, so these materials are also measured with diffuse illumination.

1. Scope

1.1 This practice provides a way of specifying the angular and spatial conditions of measurement and angular selectivity of a method of measuring the spectral reflectance factors of opaque gonioapparent materials, for a small number of sets of geometric conditions.

1.2 Measurements to characterize the appearance of retroreflective materials are of such a special nature that they are treated in other ASTM documents and are not included in the scope of this standard.

1.3 *This standard does not purport to address all of the safety concerns, if any, associated with its use. It is the responsibility of the user of this standard to establish appropriate safety and health practices and determine the applicability of regulatory limitations prior to use.*

2. Referenced Documents

2.1 *ASTM Standards:*²

- E284 Terminology of Appearance
- E308 Practice for Computing the Colors of Objects by Using the CIE System
- E1164 Practice for Obtaining Spectrometric Data for Object-Color Evaluation
- E1767 Practice for Specifying the Geometries of Observation and Measurement to Characterize the Appearance of Materials

3. Terminology

3.1 For definitions of appearance terms used in this practice, refer to Terminology E284.

4. Significance and Use

4.1 This practice is for the use of manufacturers and users of instruments to measure the appearance of gonioapparent

¹ This practice is under the jurisdiction of ASTM Committee E12 on Color and Appearance and is the direct responsibility of Subcommittee E12.03 on Geometry.

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² For referenced ASTM standards, visit the ASTM website, www.astm.org, or contact ASTM Customer Service at service@astm.org. For *Annual Book of ASTM Standards* volume information, refer to the standard's Document Summary page on the ASTM website.

materials, those writing standard specifications for such instruments, and others who wish to specify precisely the geometric conditions of multiangle spectrophotometry. A prominent example of industrial usage is the routine application of such measurements by material suppliers and automobile manufacturers to measure the colors of metallic paints and plastics.

5. Components of Apparatus

5.1 The apparatus shall consist of one or more illuminators and one or more spectrometric receivers at fixed or adjustable angles with respect to a reference plane, a means of positioning specimens in a reference plane, a means of indicating the area on the specimen to be measured, shielding to avoid stray light, and a means of displaying spectral or colorimetric data and/or communicating such data to a data-recorder or computer. (The terms “light,” “illuminator,” “illumination,” and “illuminance” are used here for simplicity, though the corresponding terms “radiant power,” “irradiator,” “irradiation,” and “irradiance” would be more accurate when the incident flux includes ultraviolet flux, as is necessary if the appearance of a fluorescent material is measured.)

6. Geometric Types of Apparatus

6.1 The geometric configuration of the instrument may be uniplanar, annular, circumferential, or diffuse. In all cases, the specimen is taken to be a flat surface lying in a plane called the “reference plane,” which is designated the x, y plane. When there is a single directional illuminator, the x direction is the direction of the projection of the axis of the incident beam on the reference plane. If there are several directional illuminators or a single diffuse illuminator, the direction of the x -axis must be selected and specified. The area of the reference plane on which measurements are made is called the “sampling aperture” and the center of that area is designated the origin, o , of the geometric space used to specify the configuration. The normal to the sampling aperture, at the origin, is the $-z$ -axis. Angles subtended at the origin and measured from that normal are called “anormal angles.” The specular direction is the direction of the beam from a directional illuminator after

specular reflection by an ideal plane mirror at the sampling aperture. Angles subtended at the origin and measured from the specular direction are called “aspecular angles” and are positive in sign when measured in the direction toward the normal. The normal and the axis of a directional illuminator define a plane, known as the “plane of incidence.” The specular direction necessarily lies in that plane.

6.1.1 To facilitate simple and precise geometric specification of the sampling aperture, it shall be either circular or rectangular.

6.1.2 To facilitate simple and precise geometric specification of directional influx or efflux distributions, they shall be either conical or pyramidal. For purposes of describing geometry by functional notation, a diffuse distribution may be considered a conical distribution centered on the normal and having a half angle of 90 degrees.

6.1.3 In a uniplanar configuration, a directional illuminator is used, the axes of the receivers lie in the plane of incidence, and their positions are specified by aspecular angles. A uniplanar configuration is illustrated in Fig. 1. To simplify the figure, only one receiver is shown.

6.1.3.1 For a conical influx distribution, the flux incident on the origin comes from an area of a directional illuminator uniformly filling a circle on a plane normal to the beam. For a conical efflux distribution, flux from the origin is uniformly collected and evaluated over an area of the receiver that is a circle on a plane normal to the beam. A uniplanar configuration with conical influx and efflux distributions is illustrated in Fig. 2. To simplify the figure, only one receiver is shown.

6.1.3.2 For a pyramidal influx distribution, flux incident on the origin comes from an area of a directional illuminator uniformly filling a rectangle on a plane normal to the beam. For a pyramidal efflux distribution, flux from the origin is uniformly collected and evaluated over an area of the receiver that is a rectangle on a plane normal to the beam. A pyramidal configuration can be used to subtend a small angle in the plane of incidence, to enhance angular selectivity, but have a large enough solid angle to provide adequate flux for reliable measurements. A uniplanar configuration with pyramidal influx and efflux distributions is illustrated in Fig. 3. To simplify the

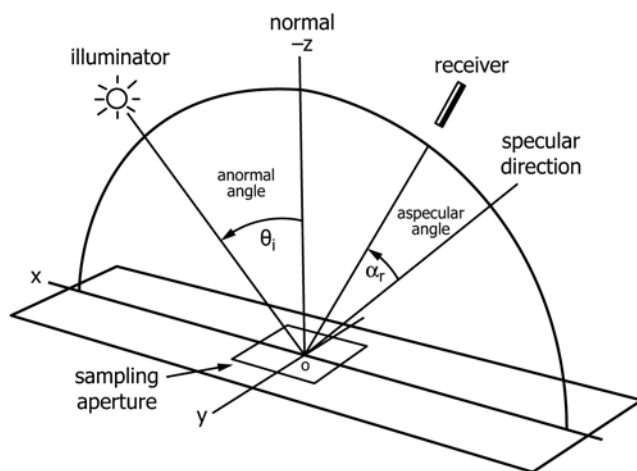


FIG. 1 Uniplanar Configuration